

**Search Notes**

Application/Control No.

10/665,654

Examiner

Linh M. Nguyen

Applicant(s)/Patent under  
Reexamination

CHEN ET AL.

Art Unit

2816

**SEARCHED**

Class	Subclass	Date	Examiner
317	261	06/28/05	Led
11	263	11	q
11	264	q	11
11	268	q	11
q	288	11	11
11	290	11	11

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner